Lifetime of MCP-PMTs

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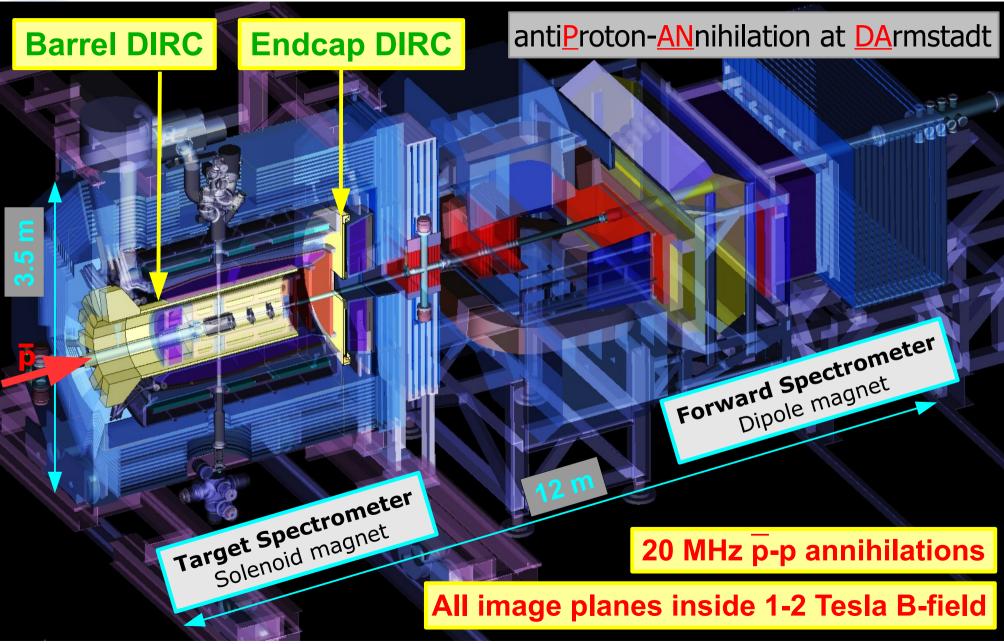
Motivation

- A few pros and cons of MCP-PMTs
- Approaches to increase lifetime
- Results of aging tests
- Outlook and summary





PANDA Detector at FAIR



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Challenges to Photon Sensors

Good geometrical resolution over a large surface

- multi-pixel sensors with ~5x5 mm² anodes (smaller for Endcap DIRC)
- Single photon detection inside B-field
 - high gain (> $5*10^5$) in up to 2 Tesla
- Time resolution for ToP and/or dispersion correction
 - very good time resolution of <100 ps for single photons

Few photons per track

- high detection efficiency η = QE * CE * GE
 [QE = quantum efficiency; CE = collection efficiency; GE = geometrical efficiency]
- low dark count rate
- Photon rates in the MHz regime
 - high rate capability with rates up to MHz/cm²
 - long lifetime with integrated anode charge of 0.5 to 2 C/cm²/y



multi-anode photomultipliers (MaPMTs)

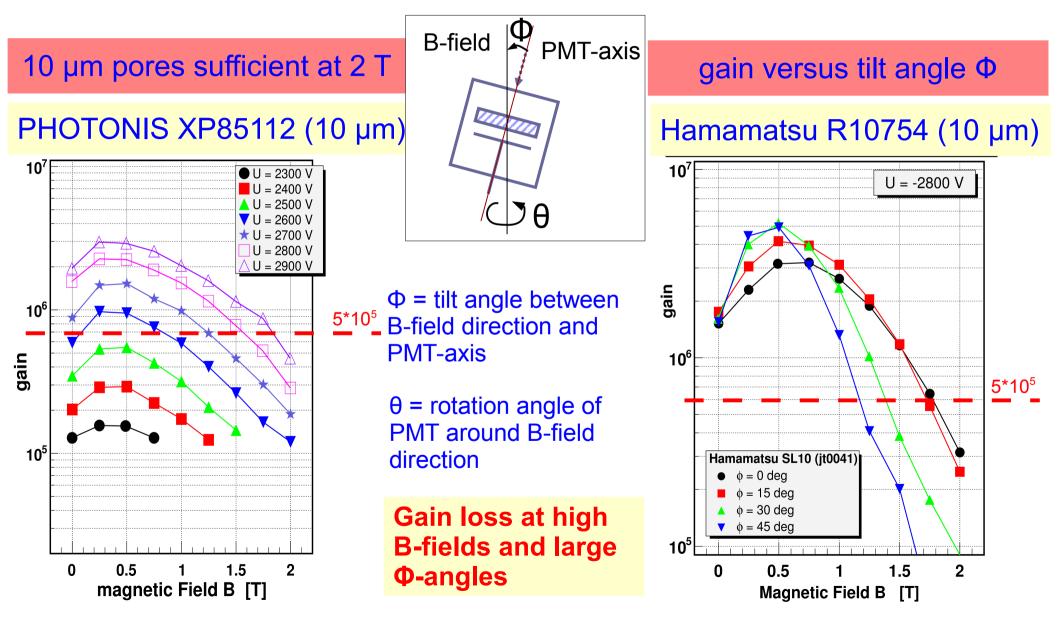
- ruled out by magnetic field
- Geiger-mode avalanche photo diodes (SiPMs)
 - huge noise is very problematic
 - radiation hardness unclear

micro-channel plate photomultipliers (MCP-PMTs)

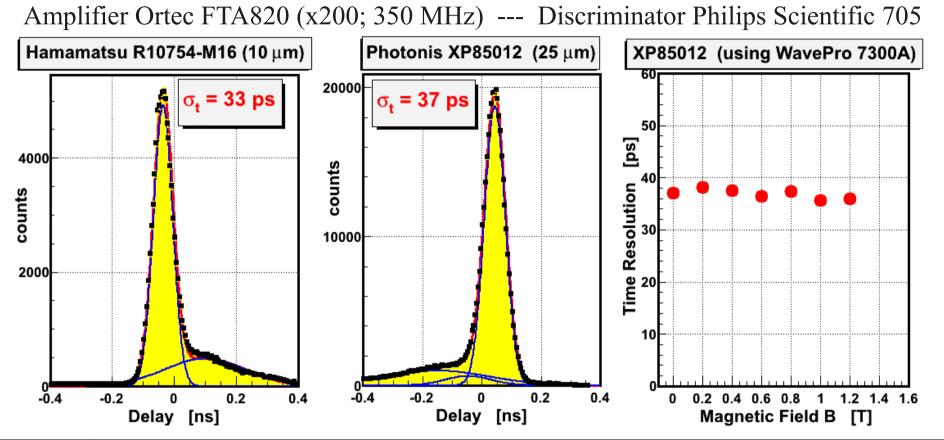
- preferred choice for PANDA DIRC
- but problems with rate capability and **aging** (mainly QE)

In the year 2011 there was no suitable sensor for the PANDA DIRCs !





Single Photon Time Resolution



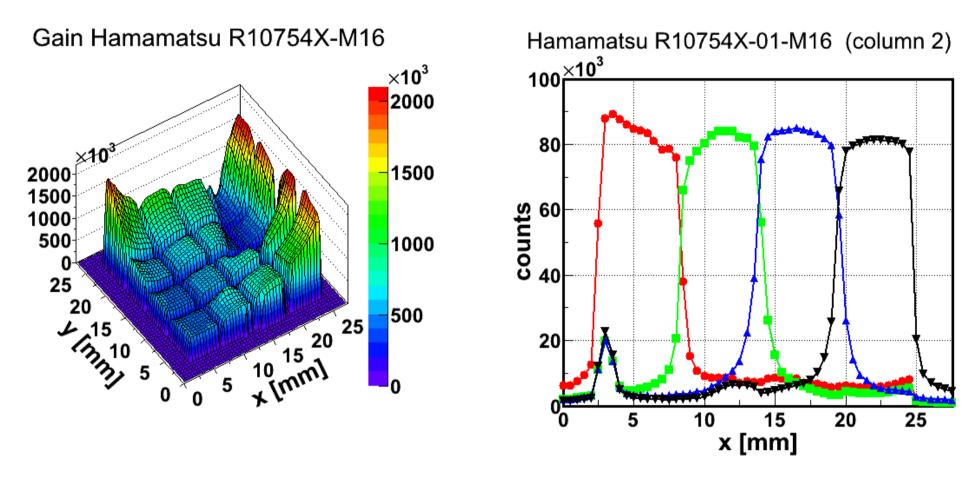
BINP	PHOTONIS				Hamamatsu		
#73	XP85011	XP85012	XP85013	XP85112	R10754	R10754X-L4	R10754X-M16
6 µm	25 µm	25 µm	25 µm	10 µm	10 µm	10 µm	10 µm
27 ps	49 ps	37 ps	51 ps	36 ps	32 ps	31 ps	33 ps

time resolution of all MCP-PMTs 50 ps and better

no dependence on the B-field

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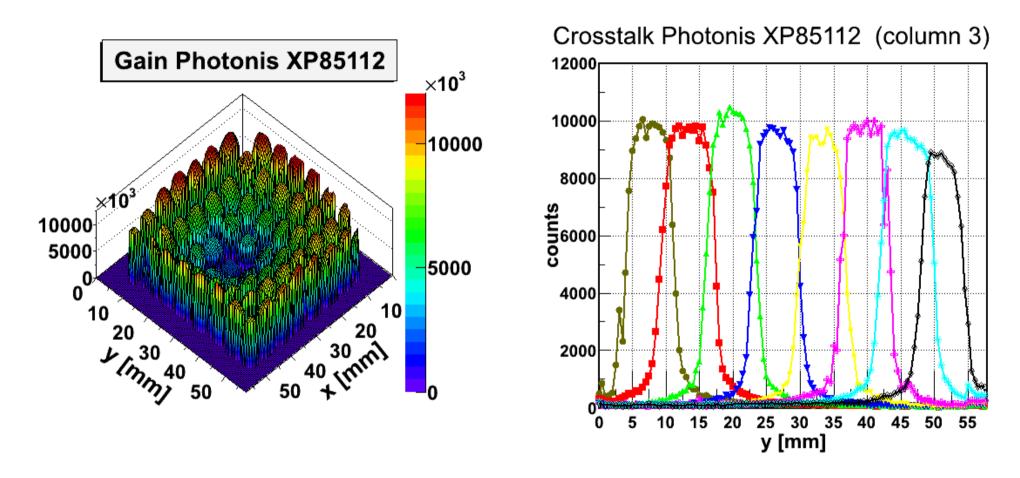
Gain and Crosstalk of R10754X-M16



- gain variations of factor 3 even within the same pixel
- 50% level of crosstalk extends only little into adjacent pixel
- Iong tails in crosstalk are of electronic nature

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Gain and Crosstalk of XP85112



substantial gain variations between pixels (in center!)

- 50% crosstalk level extends ~1 mm into adjacent pixel
- but no long crosstalk tails

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Rate Estimates for PANDA

rate capability and lifetime are the most critical issues for the application of MCP-PMTs in any high-rate experiment

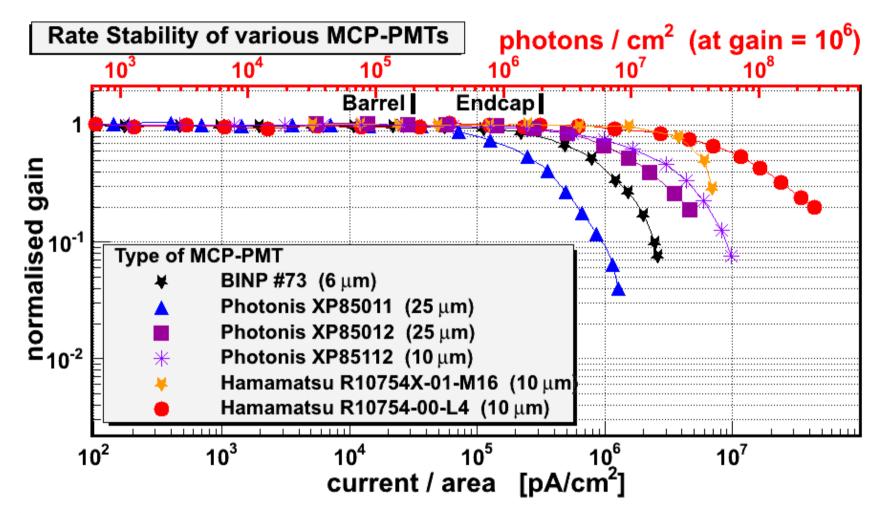
expected rates and anode charges of the PANDA DIRCs:

	total rate	anode rate (after Q.E.)	integrated anode charge / year	integrated anode charge / 10 years
	[MHz/cm ²]	[MHz/cm ²]	[C/cm ² /year] at 10 ⁶ gain (at 100% dc)	
Barrel DIRC				
at end of radiator	60	5.6	28	
at readout plane	1.7	0.2	1	5
Endcap DIRC				
at rim of radiator	19	2	10	
focussing	7.5	0.8	4	20

Endcap DIRC with much higher photon rate than Barrel DIRC → very challenging

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Rate Capability



most MCP-PMTs show stable operation to ~200-300 kHz/cm² single photons (at gain 10⁶)

R10754X and XP85112 are suitable for both PANDA DIRCs

Lifetime-Investigated MCP-PMTs

	BINP		PHOTONIS		Hamamatsu		
			XP85012	XP85112	XP85112	R10754X-01-M16	R10754X-07-M16M
pore size (µm)	6	7	25	10	10	10	10
number of pixels	1	1	8x8	8x8	8x8	4x4	4x4
active area (mm ²)	9² π	9² π	53x53	53x53	53x53	22x22	22x22
total area (mm²)	15.5² π	15.5² π	59x59	59x59	59x59	27.5x27.5	27.5x27.5
geom. efficiency (%)	36	36	81	81	81	61	61
photo cathode	multi-alkali		bi-alkali			multi-alkali	
peak Q.E.	21% @ 495 nm	21% @ 495 nm	20% @ 380 nm	23% @ 380 nm	22% @ 380 nm	21% @ 375 nm	22% @ 415 nm
comments		better vacuum, new cathode	better vacuum, polished surfaces	better vacuum, polished surfaces	better vacuum, ALD surfaces	protection layer between MCPs	further improved lifetime (ALD?)
# of tubes measured	1	2	1	1	2	1 (+1 L4)	2
							A CONTRACTOR OF

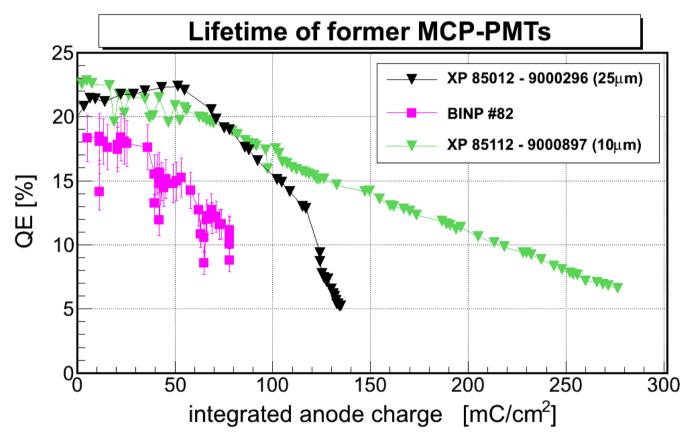
- Tubes first measured with no significant lifetime improvements
- Lifetime improved tubes currently being measured or finished
- Measurement of tube just started or not yet included in setup

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Lifetime of former MCP-PMTs

Status ~2 year ago

- BINP with Al₂O₃ film at MCP entrance to stop feedback ions
- PHOTONIS with improved vacuum and electron scrubbing of surfaces



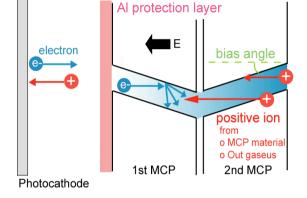
Quantum efficiency reduced by 50% or more at <200 mC/cm²

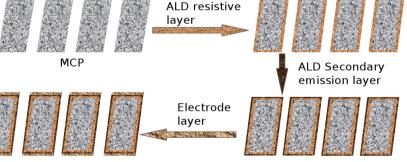
By far not sufficient for PANDA

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Approaches to Increase Lifetime

- Protection layer
 - In front of first MCP layer (older BINP and Hamamatsu)
 - disadvantage: reduction of collection efficiency
 - Between MCP layers (new Hamamatsu)
 - anode region is hermetically sealed from photo cathode region [NIM A629 (2011) 111]
- Improved vacuum + treatment of MCP surfaces [NIM A639 (2011) 148]
 - Electron scrubbing (older PHOTONIS and new BINP)
 - Atomic layer deposition (PHOTONIS)
- New photo cathode [JINST 6 C12026 (2011)]
 - $Na_2KSb(Cs) + Cs_3Sb$ (new BINP)
 - disadvantage: significantly higher dark count rate







Aging of Several MCP-PMTs

- **<u>Problem</u>**: The few aging tests existing were done in very different environments \rightarrow results are rather difficult to compare
- <u>Goal</u>: measure aging behavior for all currently available lifetimeenhanced MCP-PMTs in same environment
- **Simultaneous illumination** with common light source \rightarrow same rate
- MCP-PMTs included in aging tests of last 2 years:
 - 2x BINP
 - improved vacuum and scrubbed surfaces + new photo cathode (one finished)
 - 4x Hamamatsu R10754X
 - L4 and M16: protection layer between 1st and 2nd MCP (both finished)
 - 2x M16M: further counter measures against aging (ALD?)
 - 2x PHOTONIS XP85112
 - ALD surfaces
 - surface half covered during illumination

Measurement of MCP Lifetime

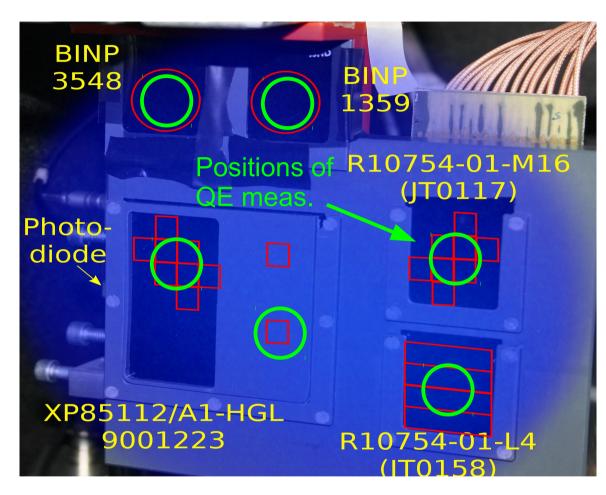
Continuous illumination

 460 nm LED at 0.25 to 1 MHz rate attenuated to single photon level
 → 3 to 14 mC/cm²/day

Permanent monitoring

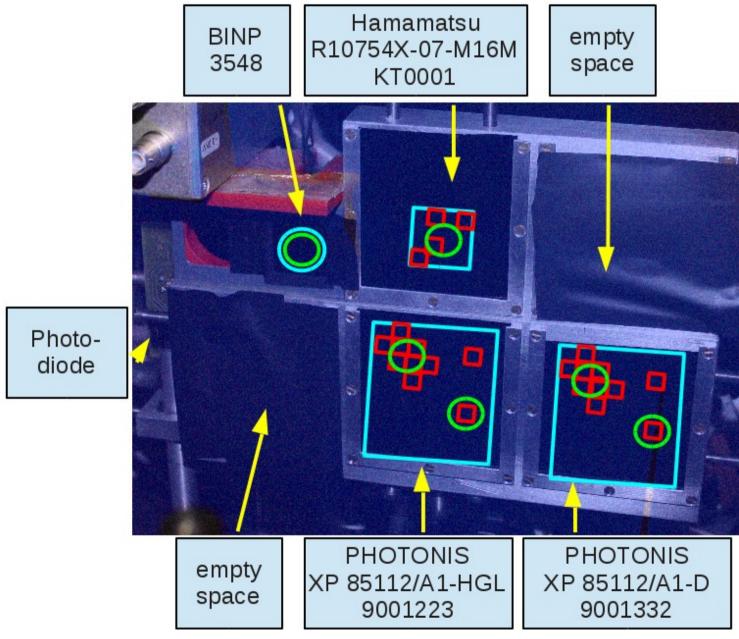
 MCP pulse heights and LED light intensity

Q.E. measurements



- 300–800 nm wavelength band with monochromator $\Delta \lambda = 1$ nm
- every few days: wavelength scan
- every several weeks: complete surface scan





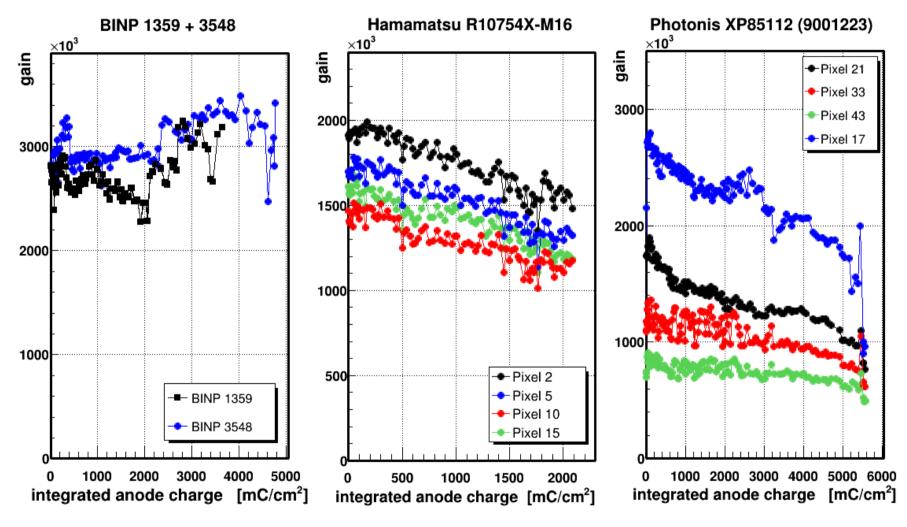
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	Sensor ID	Integral charge (Sep. 2, 2013) [mC/cm ²]	Diff. charge (maximum) [mC/cm²/d]	# of mea- surements	# of QE scans	Comments
tonis 5112	9001223	5570	13.4	123	11	Start: 23 Aug. 11 ongoing
Photo XP851	9001332	2261	14.1	27	3	Start: 12 Dec. 12 ongoing
Л	JT0117 (M16)	2086	14.1	86	7	Start: 23 Aug. 11 Stop: 24 Jul. 12
mamats 10754X	JT0158 (L4)	649	6.3	83	8	Start: 23 Aug. 11 Stop: 6 Aug. 12
Hama R10	KT0001 (M16M)	131	16.7	3	1	Start: 20 Aug. 13 ongoing
-	KT0002 (M16M)					not yet started
BINP	1359	3648	10.6	90	8	Start: 21 Oct. 11 Stop: 06 May 13
BI	3548	4779	11.7	100	8	Start: 21 Oct. 11 ongoing

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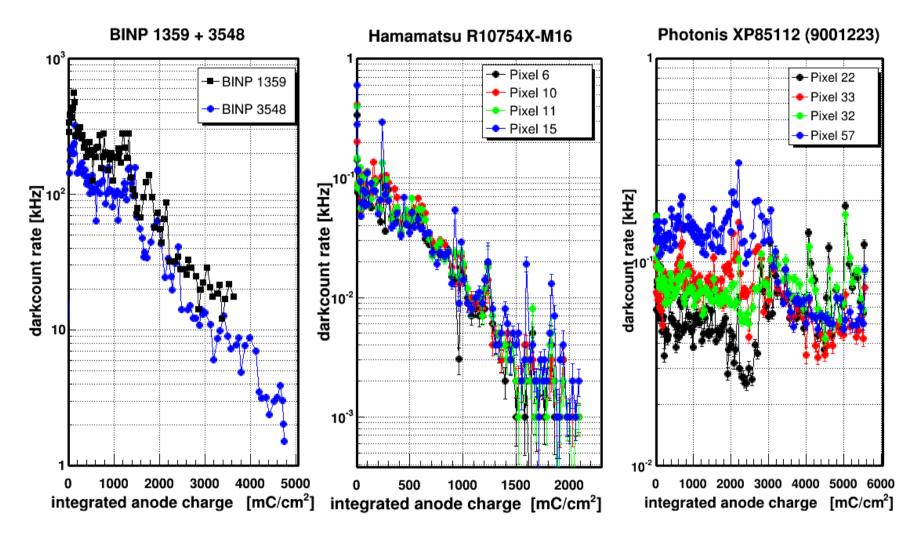
Gain vs. Integrated Anode Charge



Only moderate gain changes
 This was different in the former MCP-PMTs !

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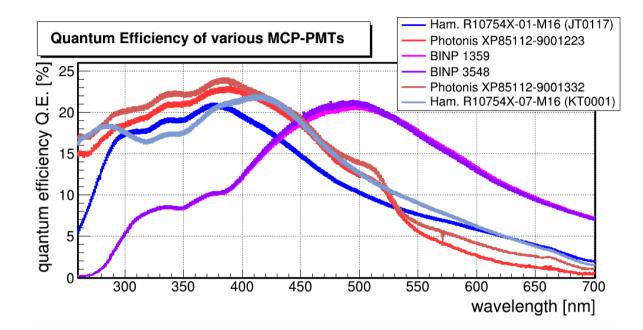
Darkcount vs. Anode Charge



Only few changes of darkcount rate for PHOTONIS XP85112
 Big reduction in BINP and Hamamatsu R10754X

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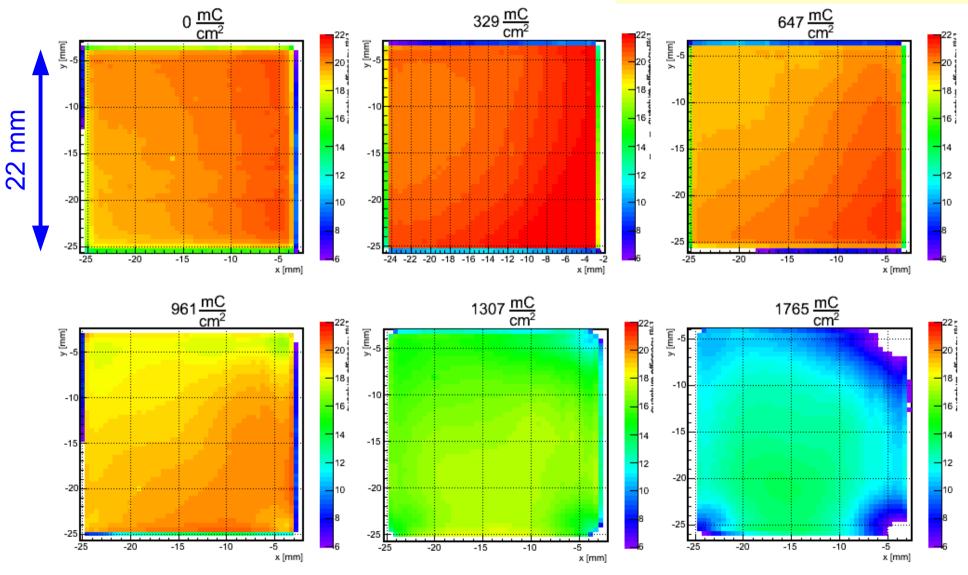
Quantum efficiency



MCP-PMT	Peak Q.E. (nm)	Photo cathode
XP85112/A1 ⁻ HGL (1223)	390	bi-alkali
R10754X-01-M16	375	multi-alkali
R10754X-07-M16M	415	bi-alkali
BINP 1359	495	$Na_{2}KSb(Cs) + Cs_{3}Sb$
BINP 3548	495	$Na_2KSb(Cs) + Cs_3Sb$

Q.E. Scans (Hamamatsu R10754X-M16)

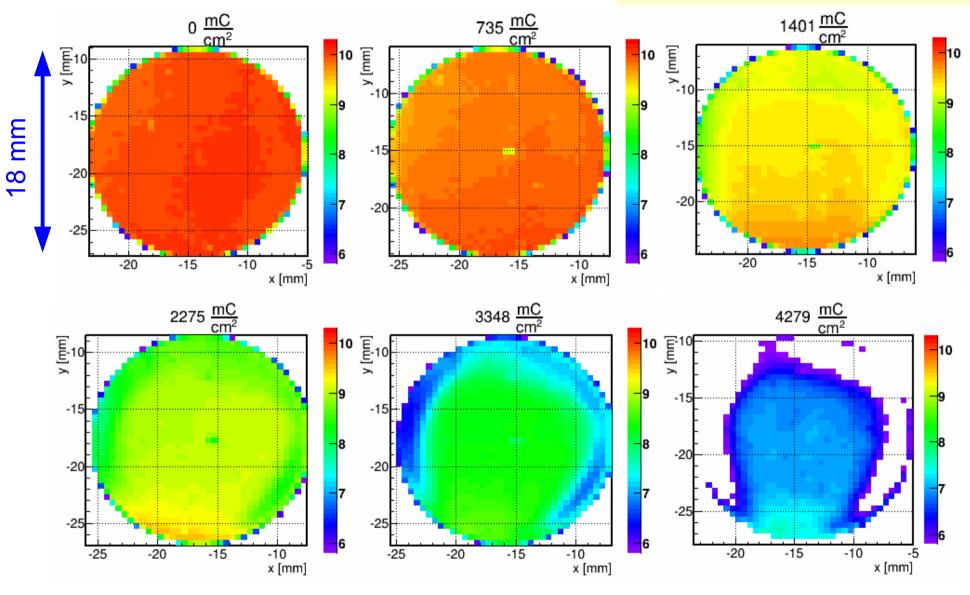
Q.E. measured at 372 nm



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Q.E. Scans (BINP 3548)

Q.E. measured at 372 nm

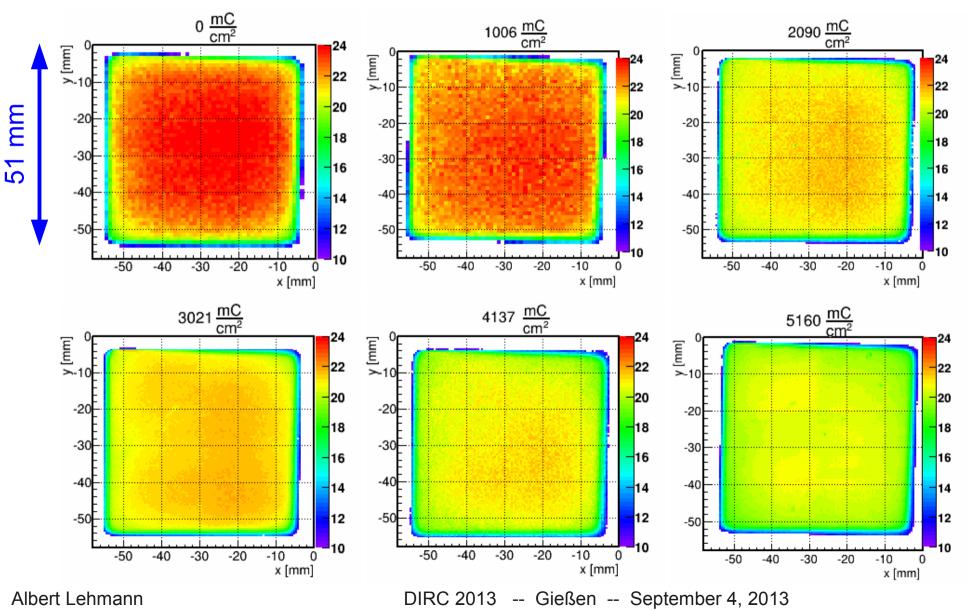


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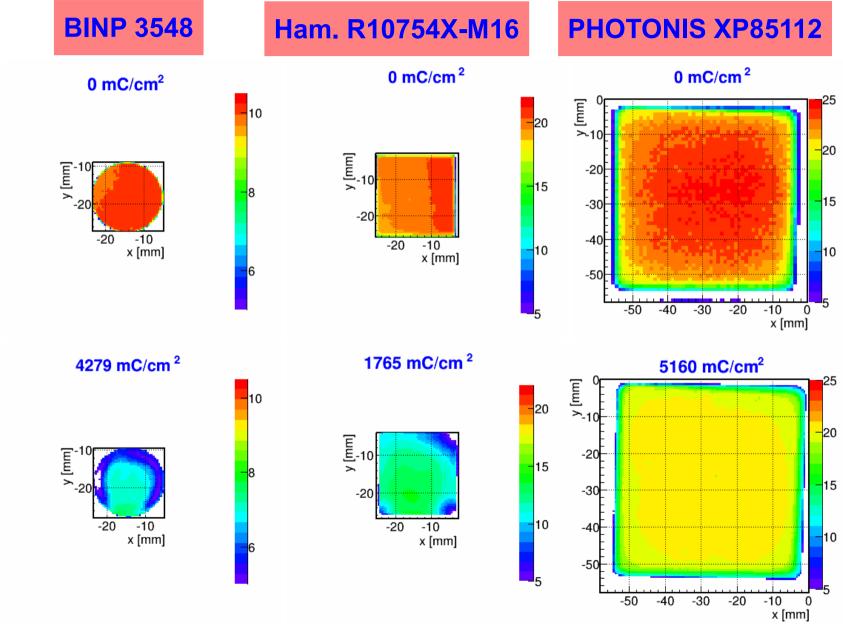
Q.E. Scans (Photonis XP85112)

9001223

Q.E. measured at 372 nm

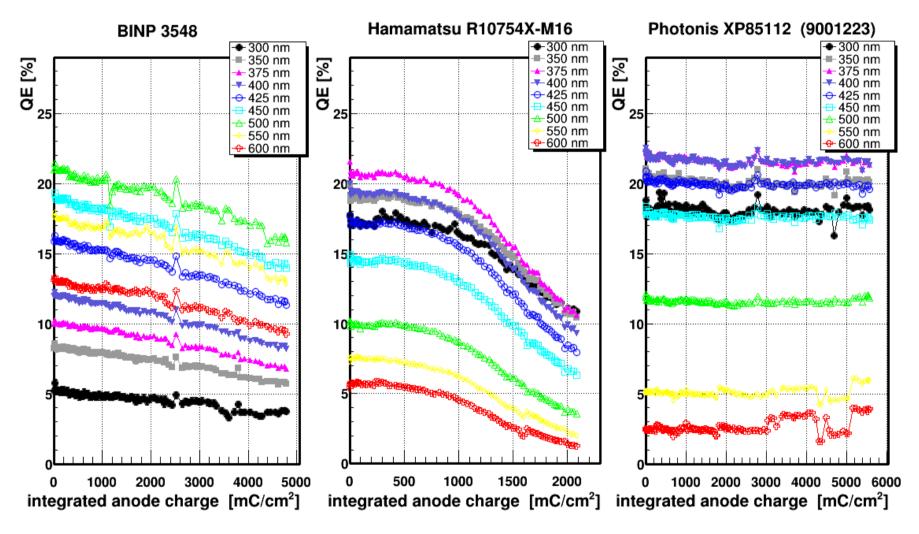


Q.E. Scans (scaled to MCP size)



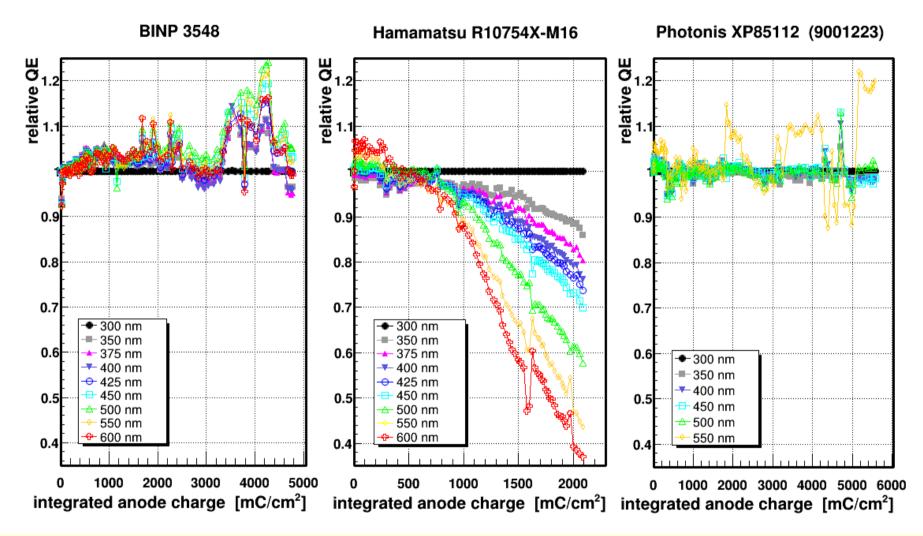
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Q.E.(λ) vs. Integral Anode Charge



Hamamatsu: Q.E. drops significantly above ~1 C/cm²
 PHOTONIS: if at all, only moderate Q.E. drop seen

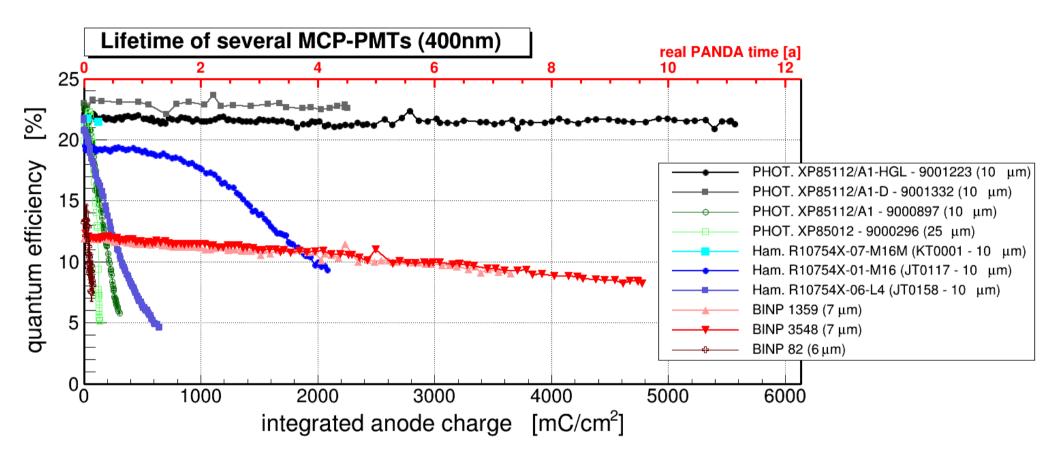
Relative Q.E.(λ) vs. Anode Charge



Ham. R10754X-M16: longer wavelengths drop faster than short ones BINP 3548 and PHOTONIS XP85112: no relative Q.E. degradation

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Lifetime of Different MCP-PMTs

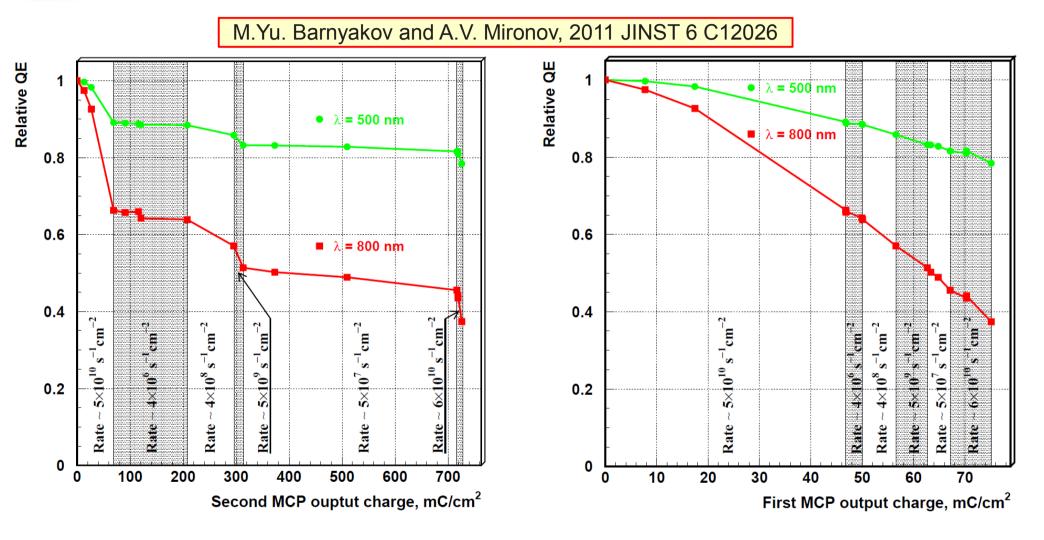


older BINP and PHOTONIS MCP-PMTs: rapid Q.E. degradation

new PHOTONIS XP85112: almost no Q.E. drop at 5.6 C/cm²

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Accelarate Aging Measurements



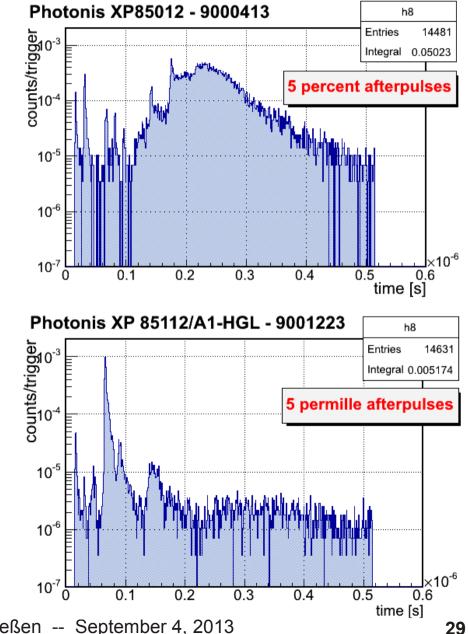
At 2nd MCP output QE degradation rate depends on count rate

At 1st MCP no correlation between QE degradation and count rate

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Estimate Lifetime from Afterpulsing

- How to guess MCP-lifetime before (and during) aging?
- Measure fraction of pulses (p.e.) followed by an afterpulse (ion)
 - The higher the fraction of afterpulses the higher the amount of restgas inside tube
 - Time delay spectrum may allow to guess the type of ions
- New MCP-PMT with ALD surfaces shows lowest afterpulsing.
- More statistics (= PMTs) needed!



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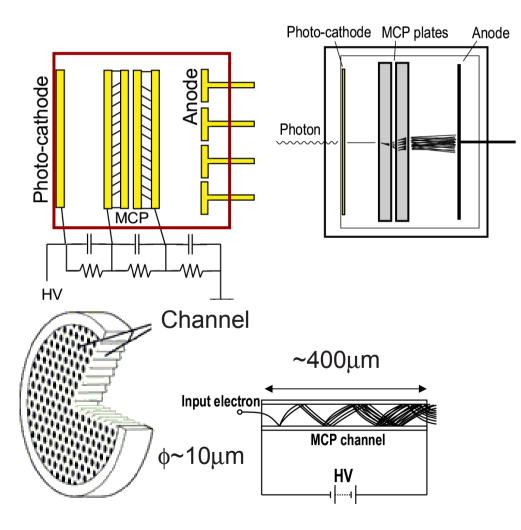
- Latest MCP-PMT models fulfill most requirements of PANDA DIRC.
- Significant increase of lifetime of MCP-PMTs due to the recent improvements in design
 - huge step forward !
 - equipping the PANDA DIRCs with MCP-PMTs seems possible

ALD technique appears very promising (reached ~6 C/cm²)

- Further improvements could possibly come from
 - modified photo cathodes (see BINP)
 - MCP materials with less outgassing (e.g., borsilicate glass instead of lead glass)

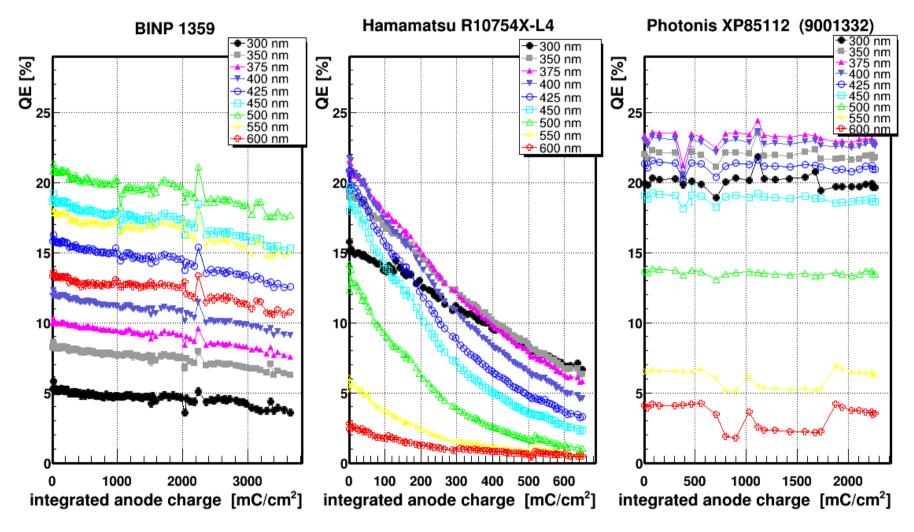
Microchannel-Plate PMT

electron multiplication in glass capillaries (\varnothing \approx 10-25 μ m)



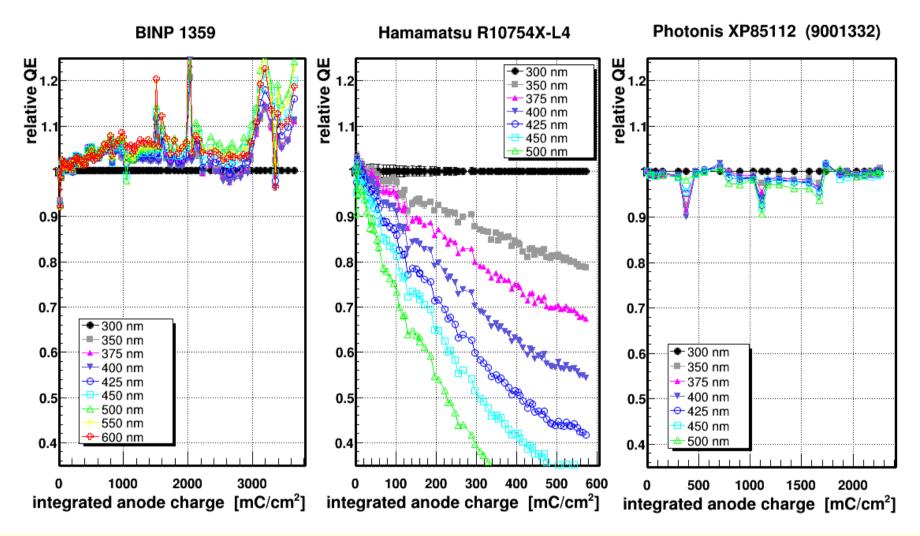
- usable in high magnetic fields
- high gain.
 - >10⁶ with 2 MCP stages
 - single photon sensitivity
- very fast time response:
 - signal rise time = 0.3 1.0 ns
 - TTS < 50 ps
- Iow dark count rate
- quantum efficiency comparable to that of standard vacuum PMTs
- multi-anode PMTs available
- caveats:
 - lifetime (QE drops)
 - price

Q.E.(λ) vs. Integral Anode Charge



Hamamatsu: tube was damaged before illumination
 PHOTONIS: no Q.E. drop seen

Relative Q.E.(λ) vs. Anode Charge



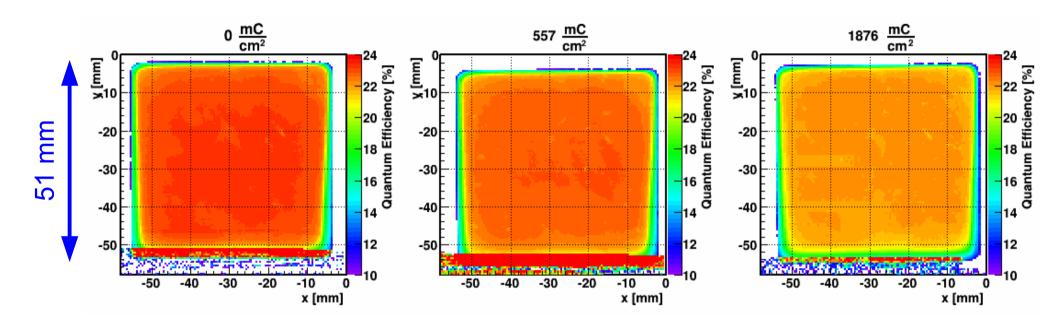
Ham. R10754X-L4: longer wavelengths drop faster than short ones BINP 1359 and PHOTONIS XP85112: no relative Q.E. degradation

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Q.E. Scans (Photonis XP85112)

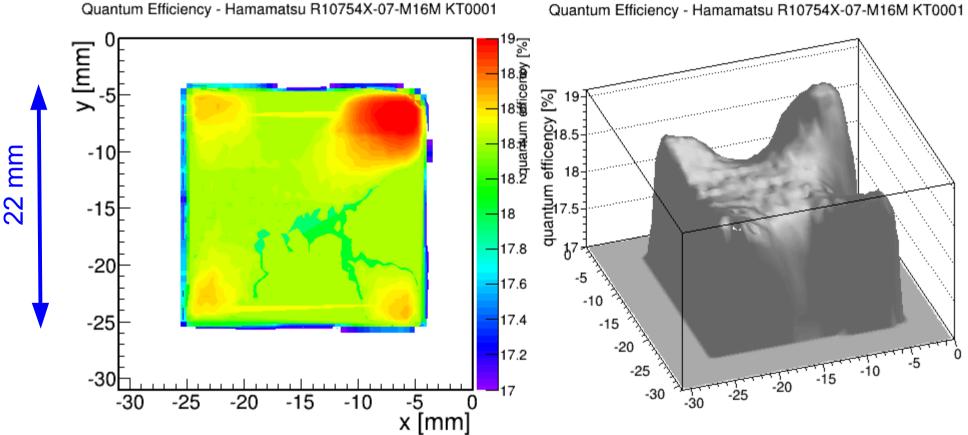
9001332

Q.E. measured at 372 nm



Q.E. Scans (Hamamatsu R10754X-M16M)

Q.E. measured at 372 nm



Quantum Efficiency - Hamamatsu R10754X-07-M16M KT0001

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